Data sheet acquired from Harris Semiconductor SCHS211E

High-Speed CMOS Logic 8-Stage Shift and Store Bus Register, Three-State

November 1997 – Revised December 2010

Features

- ¥ Buffered Inputs
- ¥ Separate Serial Outputs Synchronous to Both Positive and Negative Clock Edges For Cascading
- **¥ Fanout (Over Temperature Range)**
 - Standard Outputs......10 LSTTL Loads - Bus Driver Outputs15 LSTTL Loads
- ¥ Wide Operating T emperature Rang e . . . -55°C to 125°C
- ¥ Balanced Propagation Delay and Transition Times
- ¥ Signi Cant Power Reduction Compared to LSTTL Logic ICs
- **¥ HC Types**
 - 2V to 6V Operation
 - High Noise Immunity: N_{IL} = 30%, N_{IH} = 30% of V_{CC} at $V_{CC} = 5V$

¥ HCT Types

- 4.5V to 5.5V Operation
- Direct LSTTL Input Logic Compatibility, V_{IL} = 0.8V (Max), V_{IH} = 2V (Min)
- CMOS Input Compatibility, I_I \leq 1 μ A at V_{OL}, V_{OH}

Description

The ÕHC4094and CD74HCT4094 are 8-stage serial shift registers having a storage latch associated with each stage for strobing data from the serial input to parallel buffered three-state outputs. The parallel outputs may be connected directly to common bus lines. Data is shifted on positive clock transitions. The data in each shift register stage is transferred to the storage register when the Strobe input is high. Data in the storage register appears at the outputs whenever the Output-Enable signal is high.

Two serial outputs are available for cascading a number of these devices. Data is available at the ${\sf QS}_1$ serial output terminal on positive clock edges to allow for high-speed operation in cascaded system in which the clock rise time is fast. The same serial information, available at the QS2 terminal on the next negative clock edge, provides a means for cascading these devices when the clock rise time is slow.

Ordering Information

TEMP. RANGE (°C)	PACKAGE
-55 to 125	16 Ld CERDIP
-55 to 125	16 Ld PDIP
-55 to 125	16 Ld SOIC
-55 to 125	16 Ld SOIC
-55 to 125	16 Ld SOIC
-55 to 125	16 Ld SOP
-55 to 125	16 Ld TSSOP
-55 to 125	16 Ld TSSOP
-55 to 125	16 Ld TSSOP
-55 to 125	16 Ld PDIP
-55 to 125	16 Ld SOIC
-55 to 125	16 Ld SOIC
-55 to 125	16 Ld SOIC
	(°C) -55 to 125 -55 to 125

NOTE: When ordering, use the entire part number. The suf esses 96 and R denote tape and reel. The suf \(\bar{\mathcal{L}}\x \text{T denotes a small-quantity}\) reel of 250.

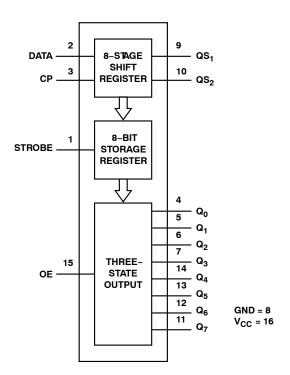
Pinout

CD54HC4094 (CERDIP) CD74HC4094 (PDIP, SOIC, SOP, TSSOP) CD74HCT4094 (PDIP, SOIC)

TOP VIEW STROBE 1 16 V_{CC} 15 OE DATA 2 14 Q₄ CP 3 13 Q₅ 12 Q₆ Q₁ 5 $Q_2 = 6$ 11 Q₇ 10 QS₂ 9 QS₁ GND 8

CAUTION: These devices are sensitive to electrostatic discharge. Users should follow proper IC Handling Procedures. Copyright 🗓 2003, Texas Instruments Incorporated

Functional Diagram



TRUTH TABLE

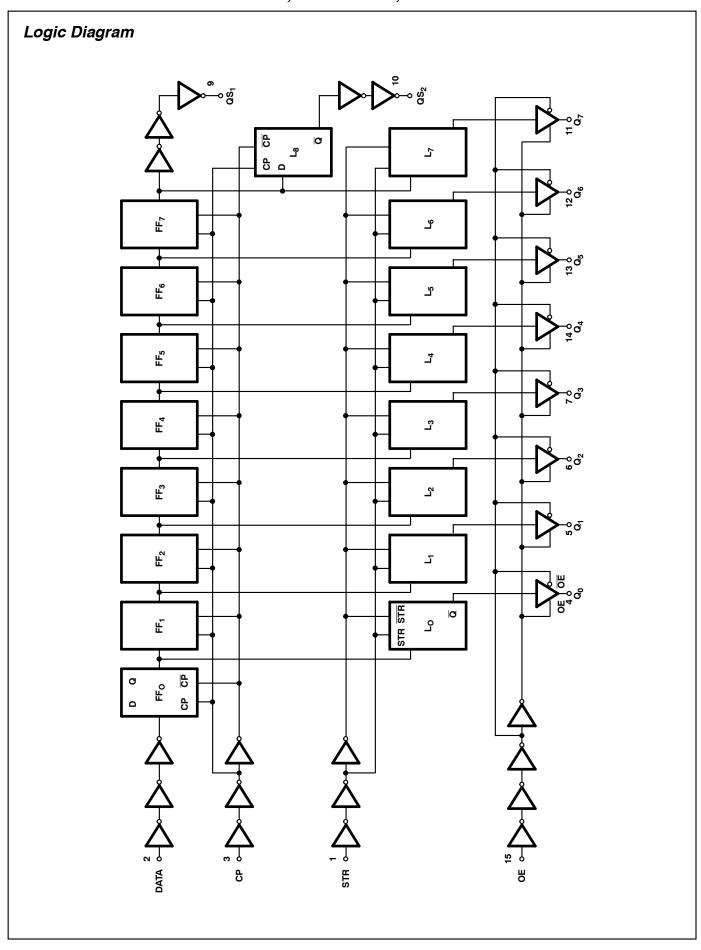
	INPU	ITS		PARALLEL	OUTPUTS	SERIAL OUTPUTS		
СР	OE	STR	D	Q ₀	Q _n	QS ₁ (NOTE 1)	QS ₂	
1	L	Х	Х	Z	Z	QÕ6	NC	
\	L	Х	Х	Z	Z	NC	Q ₇	
1	Н	L	Х	NC	NC	QÕ6	NC	
1	Н	Н	L	L	Q _n –1	QÕ6	NC	
1	Н	Н	Н	Н	Q _n –1	QÕ6	NC	
<u> </u>	Н	Н	Н	NC	NC	NC	Q ₇	

H = High Voltage Level, L = Low Voltage Level, X = DonÕt Care, NC = No charge, Z = High Impedance Off-state,

↑ = Transition from Low to High Level, ↓ = Transition from High to Low.

NOTE:

1. At the positive clock edge the information in the seventh register stage is transferred to the 8th register stage and QS1 output.



Thermal Information

Package Thermal Impedance, θ_{JA} (see Note 2):
E (PDIP) Package
M (SOIC) Package73°C/W
NS (SOP) Package
PW (TSSOP) Package
Maximum Junction Temperature (Plastic Package) 150°
Maximum Storage Temperature Range65°C to 150°
Maximum Lead Temperature (Soldering 10s)300°
SOIC - Lead Tips Only)

Operating Conditions

Temperature Range (T _A)55°C to 125°C
Supply Voltage Range, V _{CC}
HC Types2V to 6V
HCT Types
DC Input or Output Voltage, $V_{I},V_{O}\dots\dots\dots\dots$ 0V to V_{CC}
Input Rise and Fall Time
2V
4.5V
6V

CAUTION: Stresses above those listed in OAbsoluteMaximum RatingsÓnay cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

2. The package thermal impedance is calculated in accordance with JESD 51-7.

DC Electrical Speci¿cations

		TES CONDI		v _{cc}		25°C		-40°C T	O 85°C	-55°C T	O 125°C	
PARAMETER	SYMBOL	V _I (V)	I _O (mA)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES												
High Level Input	V _{IH}	-	-	2	1.5	ı	-	1.5	-	1.5	_	V
Voltage				4.5	3.15	-	-	3.15	-	3.15	_	٧
				6	4.2	1	-	4.2	_	4.2	_	>
Low Level Input	V _{IL}	-	-	2	-	-	0.5	_	0.5	_	0.5	V
Voltage				4.5	_	-	1.35	-	1.35	-	1.35	V
				6	_	-	1.8	_	1.8	_	1.8	V
High Level Output	V _{OH}	V _{IH} or V _{IL}	-0.02	2	1.9	-	-	1.9	_	1.9	_	V
Voltage CMOS Loads			-0.02	4.5	4.4	-	-	4.4	-	4.4	_	V
omeo Loddo			-0.02	6	5.9	-	-	5.9	-	5.9	-	V
High Level Output	7		-	-	-	-	-	-	-	-	-	V
Voltage TTL Loads		,	-4	4.5	3.98	-	-	3.84	-	3.7	-	V
TTE Educa			-5.2	6	5.48	-	-	5.34	-	5.2	-	V
Low Level Output	V _{OL}	V _{IH} or V _{IL}	0.02	2	-	-	0.1	-	0.1	-	0.1	V
Voltage CMOS Loads			0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
OWIGO Educa			0.02	6	_	-	0.1	-	0.1	-	0.1	V
Low Level Output	7		-	-	_	-	-	-	-	-	-	V
Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V
112 20003			5.2	6	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	IĮ	V _{CC} or GND	-	6	-	_	±0.1	-	±1	-	±1	μА
Quiescent Device Current	lcc	V _{CC} or GND	0	6	-	ı	8	-	80	-	160	μА

DC Electrical Speci¿cations (Continued)

		TES CONDI		V _{CC}		25°C		-40°C T	O 85°C	-55°C T	O 125°C	
PARAMETER	SYMBOL	V _I (V)	I _O (mA)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HCT TYPES												
High Level Input Voltage	V _{IH}	_	-	4.5 to 5.5	2	-	-	2	_	2	-	٧
Low Level Input Voltage	V _{IL}	-	-	4.5 to 5.5	-	-	0.8	-	0.8	-	0.8	V
High Level Output Voltage CMOS Loads	V _{OH}	V _{IH} or V _{IL}	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
High Level Output Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	=	3.7	=	V
Low Level Output Voltage CMOS Loads	V _{OL}	V _{IH} or V _{IL}	0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
Low Level Output Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	I _I	V _{CC} and GND	0	5.5	-	-	±0.1	-	±1	-	±1	μА
Quiescent Device Current	Icc	V _{CC} or GND	0	5.5	-	-	8	-	80	-	160	μА
Additional Quiescent Device Current Per Input Pin: 1 Unit Load	ΔI _{CC} (Note 3)	V _{CC} -2.1	-	4.5 to 5.5	-	100	360	-	450	-	490	μА

NOTE:

HCT Input Loading Table

INPUT	UNIT LOADS
D	0.4
CP, OE	1.5
STR	1.0

NOTE: Unit Load is ΔI_{CC} limit speci@ed in DC Electrical Table, e.g., 360µA max at 25°C.

Prerequisite for Switching Speci∂cations

			25°C		-40°C T	O 85°C	-55°C TO 125°C		
CHARACTERISTIC	SYMBOL	V _{CC} (V)	MIN	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES									
CP Pulse Width	t _W	2	80	-	100	-	120	-	ns
		4.5	16	-	20	-	24	-	ns
		6	14	-	17	-	20	-	ns
STR Pulse Width	t _{WH}	2	80	-	100	-	120	-	ns
		4.5	16	-	20	-	24	-	ns
		6	14	-	17	-	20	_	ns

^{3.} For dual-supply systems theoretical worst case (γ = 2.4V, V_{CC} = 5.5V) specification is 1.8mA.

Prerequisite for Switching Speci@cations (Continued)

			25	5°C	-40°C 1	ΓΟ 85°C	-55°C T	O 125°C	
CHARACTERISTIC	SYMBOL	V _{CC} (V)	MIN	MAX	MIN	MAX	MIN	MAX	UNITS
Data Set-up Time	t _{SU}	2	50	-	65	-	75	-	ns
		4.5	10	-	13	-	15	-	ns
		6	9	-	11	-	13	-	ns
Data Hold Time	t _H	2	3	-	3	-	3	-	ns
		4.5	3	-	3	-	3	-	ns
		6	3	-	3	-	3	-	ns
STR Set-up Time	t _{SU}	2	100	-	125	-	150	-	ns
		4.5	20	-	25	_	30	_	ns
		6	17	-	21	-	26	-	ns
STR Hold Time	t _H	2	0	-	0	-	0	-	ns
		4.5	0	-	0	-	0	-	ns
		6	0	-	0	-	0	_	ns
Maximum CP Frequency	f _{CL (MAX)}	2	6	-	5	-	4	_	MHz
		4.5	30	-	24	-	20	_	MHz
		6	35	-	28	-	24	_	MHz
HCT TYPES	•		•		•	•	•		•
CP Pulse Width	t _W	4.5	16	-	20	-	24	-	ns
STR Pulse Width	t _{WH}	4.5	16	-	20	-	24	_	ns
Data Set-up Time	t _{SU}	4.5	10	-	13	-	15	-	ns
Data Hold Time	t _H	4.5	4	-	4	-	4	-	ns
STR Set-up Time	t _{SU}	4.5	20	-	25	-	30	-	ns
STR Hold Time	t _H	4.5	0	-	0	-	0	-	ns
Maximum CP Frequency	f _{CL (MAX)}	4.5	30	-	24	-	20	-	MHz

Switching Speci \cite{l} cations Input t_r , t_f = 6ns

		TEST	v _{cc}	25°C			-40°C T	O 85°C	-55°C TO 125°C		
PARAMETER	SYMBOL	CONDITIONS	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES											
Propagation Delay Time (Figure 1)	t _{PLH,} t _{PHL}	C _L = 50pF	2	-	-	150	-	190	-	225	ns
CP to QS ₁			4.5	-	-	30	-	38	-	45	ns
		C _L =15pF	5	-	12	_	-	_	-	_	ns
		C _L = 50pF	6	-	-	26	-	33	-	38	ns
CP to QS ₂	t _{PLH} ,	C _L = 50pF	2	-	-	135	-	170	-	205	ns
	t _{PHL}		4.5	-	-	27	-	34	-	41	ns
		C _L =15pF	5	-	11	_	-	_	-	_	ns
		C _L = 50pF	6	-	-	23	-	29	-	35	ns
CP to Q _n	t _{PLH} ,	C _L = 50pF	2	-	-	195	-	245	-	295	ns
	t _{PHL}		4.5	-	-	39	-	49	-	59	ns
			5	-	16	-	-	_	-	_	ns
			6	-	-	33	-	42	-	50	ns
STR to Q _n	t _{PLH} ,	C _L = 50pF	2	-	-	180	-	225	-	270	ns
	t _{PHL}		4.5	-	-	36	-	45	-	54	ns
			6	-	-	31	_	38	_	46	ns

Switching Speci $\cite{locations}$ Input t_r , t_f = 6ns (Continued)

		TEST	v _{cc}		25°C		_40°C T	O 85°C	–55°C T	O 125°C	
PARAMETER	SYMBOL	CONDITIONS	(S)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
Output Enable to Q _n	t _{PZH} , t _{PZL}	C _L = 50pF	2	-	-	175	-	220	-	265	ns
]	4.5	-	-	35	-	44	-	53	ns
]	6	-	_	30	-	37	-	45	ns
Output Disable to Qn	t _{PHZ} , t _{PLZ}	C _L = 50pF	2	-	-	125	-	155	-	190	ns
			4.5	-	-	25	-	31	-	38	ns
			6	-	-	21	-	26	-	32	ns
Output Transition Time	t _{TLH} , t _{THL}	C _L = 50pF	2	-	_	75	-	95	-	110	ns
]	4.5	-	-	15	-	19	-	22	ns
]	6	-	-	13	-	16	-	19	ns
Output Disabling Time	t _{PHZ} , t _{PLZ}	C _L =15pF	5	-	10	_	-	-	-	-	ns
Maximum CP Frequency	f _{MAX}	C _L =15pF	5	-	60	_	-	-	-	-	MHz
Input Capacitance	C _{IN}	C _L = 50pF	_	_	_	10	-	10	-	10	pF
Power Dissipation Capacitance (Notes 4, 5)	C _{PD}	C _L =15pF	5	-	90	-	-	-	-	-	pF
Three-State Output Capacitance	Co	C _L = 50pF	-	-	-	15	-	15	-	15	pF
HCT TYPES											
Propagation Delay Time (Figure 1)	t _{PLH,} t _{PHL}	C _L = 50pF	4.5	_	-	39	-	-	-	_	ns
CP to QS ₁		C _L =15pF	5	-	16	_	-	-	-	-	ns
CP to QS ₂	t _{PLH} ,	C _L = 50pF	4.5	-	-	36	-	-	-	-	ns
	t _{PHL}	C _L =15pF	5	-	15	_	-	-	-	-	ns
CP to Q _n	t _{PLH} ,	C _L = 50pF	4.5	-	-	43	-	-	-	-	ns
	t _{PHL}	C _L =15pF	5	-	18	-	-	_	-	-	ns
STR to Q _n	t _{PLH,} t _{PHL}	C _L = 50pF	4.5	-	-	39	-	-	-	-	ns
Output Enable to Q _n	t _{PZH} , t _{PZL}	C _L = 50pF	4.5	-	-	35	-	_	-	_	ns
Output Disable to Q _n	t _{PHZ} , t _{PLZ}	C _L = 50pF	4.5	-	_	35	_	-	-	-	ns
Output Transition Time	t _{TLH} , t _{THL}	C _L = 50pF	4.5	-	-	15	-	-	-	_	ns
Output Disabling Time	t _{PHZ} , t _{PLZ}	C _L =15pF	5	-	14	_	-	-	-	-	ns
Maximum CP Frequency	f _{MAX}	C _L =15pF	5	-	60	_	-	-	-	-	MHz
Input Capacitance	C _{IN}	C _L = 50pF	-	-	-	10	-	10	-	10	pF
Power Dissipation Capacitance (Notes 4, 5)	C _{PD}	C _L =15pF	5	_	110	-	-	-	-	-	pF
Three-State Output Capacitance	C _O	C _L = 50pF	-	-	-	15	-	15	-	15	pF

^{4.} $C_{\mbox{PD}}$ is used to determine the dynamic power consumption, per register.

^{5.} $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$ where f_i = Input Frequency, C_L = Output Load Capacitance, V_{CC} = Supply Voltage.

CD54/74HC4094, CD74HCT4094

Test Circuits and Waveforms

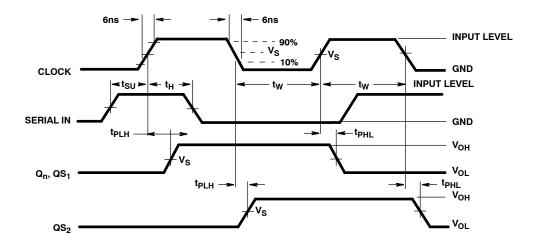
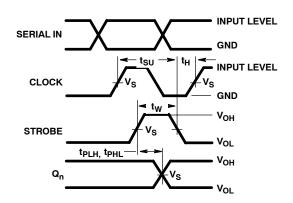


FIGURE 1. DATA PROPAGATION DELAYS, SET-UP AND HOLD TIMES



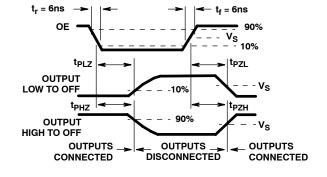


FIGURE 2. STROBE PROPAGATION DELAYS AND SET-UP AND HOLD TIMES

FIGURE 3. ENABLE AND DISABLE TIMES

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
CD54HC4094F3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	
CD74HC4094E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	
CD74HC4094EE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	
CD74HC4094M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094M96G3	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	
CD74HC4094M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094MTE4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094MTG4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094NSR	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094NSRE4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094NSRG4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094PWE4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	



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Orderable Device	Status ⁽¹⁾	Package Type	ype Package Pins Package Qty Eco Plan ⁽²⁾ Drawing		Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)	
CD74HC4094PWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094PWRE4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094PWRG3	PREVIEW	TSSOP	PW	16	2000	TBD	Call TI	Call TI	
CD74HC4094PWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094PWT	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094PWTE4	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HC4094PWTG4	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HCT4094E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	
CD74HCT4094EE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	
CD74HCT4094M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HCT4094M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HCT4094M96E4	ACTIVE	SOIC	D	16		TBD	Call TI	Call TI	
CD74HCT4094M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HCT4094ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HCT4094MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HCT4094MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HCT4094MTE4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CD74HCT4094MTG4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	





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(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF CD54HC4094, CD74HC4094:

Catalog: CD74HC4094

Military: CD54HC4094

NOTE: Qualified Version Definitions:

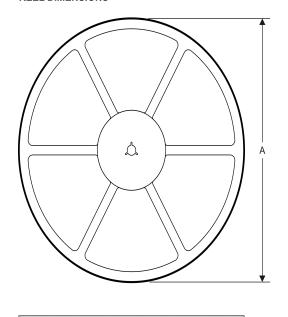
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

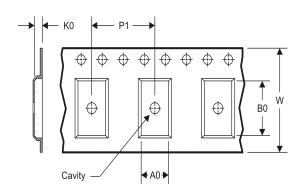
www.ti.com 20-Oct-2011

TAPE AND REEL INFORMATION

REEL DIMENSIONS



TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC4094NSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD74HC4094PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4094PWT	TSSOP	PW	16	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

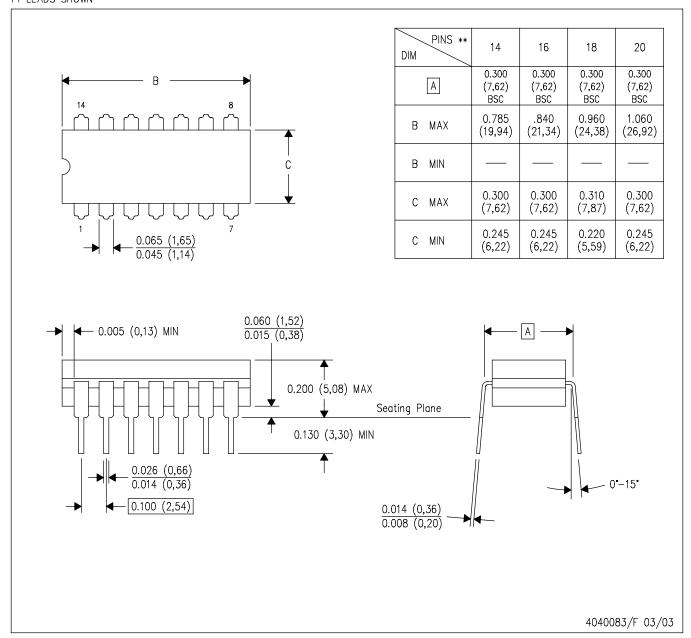
www.ti.com 20-Oct-2011



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
CD74HC4094NSR	SO	NS	16	2000	346.0	346.0	33.0	
CD74HC4094PWR	TSSOP	PW	16	2000	346.0	346.0	29.0	
CD74HC4094PWT	TSSOP	PW	16	250	346.0	346.0	29.0	

14 LEADS SHOWN

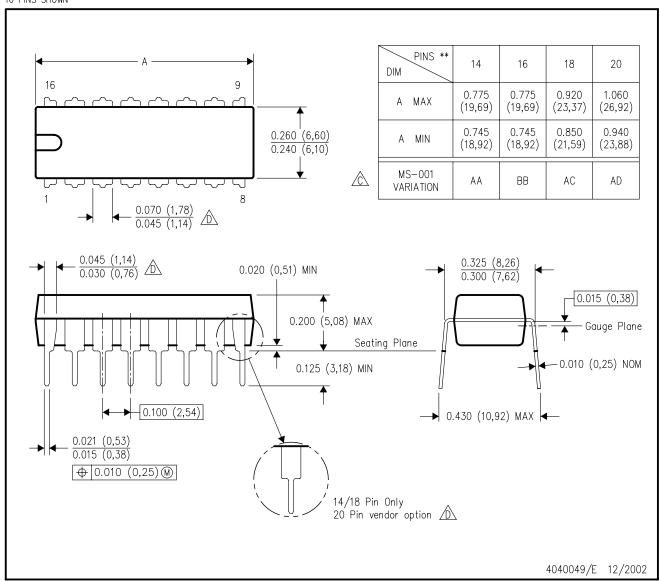


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE

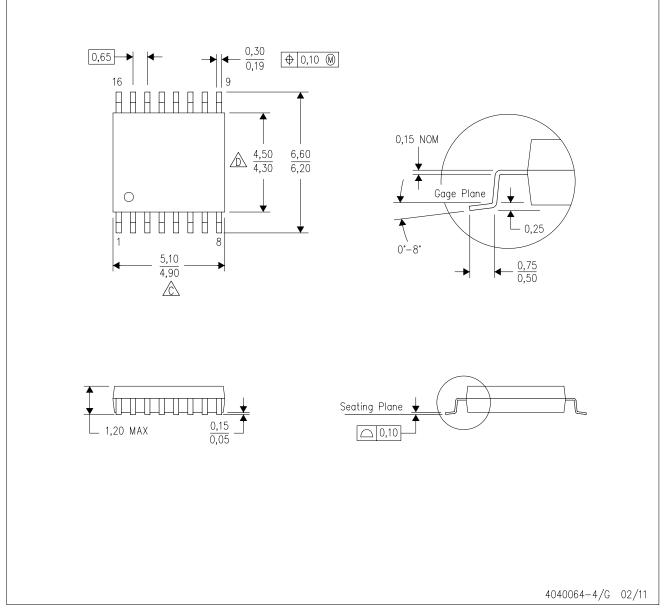


- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



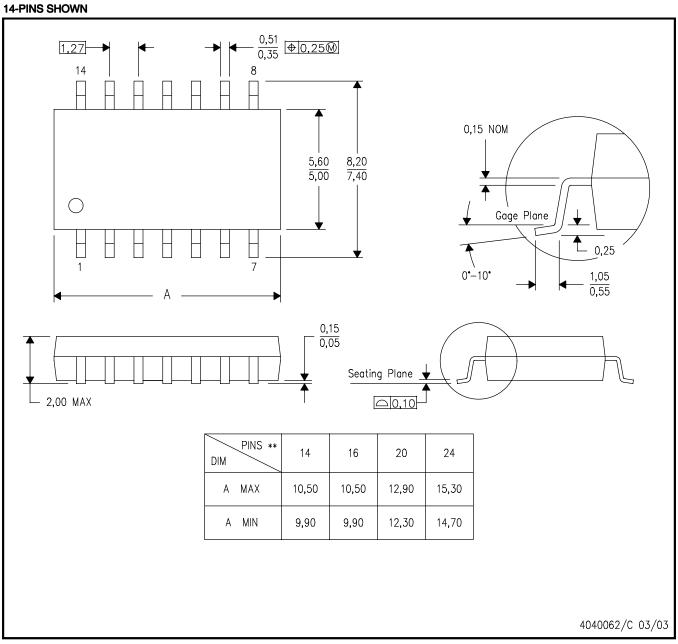
- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



MECHANICAL DATA

NS (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE



- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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